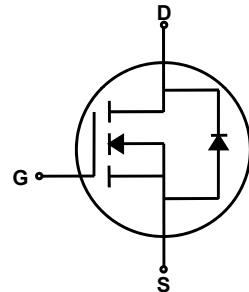


General Description

This Power MOSFET is produced using Maple semi's Advanced Super-Junction technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for AC/DC power conversion in switching mode operation for higher efficiency.

Features

- 15A, 600V, $R_{DS(on)typ} = 0.25\Omega @ V_{GS} = 10V$
- Low gate charge (typical 26nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_C = 25^\circ C$ unless otherwise noted

| Symbol | Parameter | SLP60R280S2 | SLF60R280S2 | Units |
|----------------|--|-------------|-------------|---------------|
| V_{DSS} | Drain-Source Voltage | 600 | | V |
| I_D | Drain Current - Continuous ($T_C = 25^\circ C$) | 15 | | A |
| | - Continuous ($T_C = 100^\circ C$) | 8.8 | | A |
| I_{DM} | Drain Current - Pulsed | (Note 1) | 56 | A |
| V_{GSS} | Gate-Source Voltage | | ± 30 | V |
| EAS | Single Pulsed Avalanche Energy | (Note 2) | 580 | mJ |
| I_{AR} | Avalanche Current | (Note 1) | 15 | A |
| dv/dt | Peak Diode Recovery dv/dt | (Note 3) | 15 | V/ns |
| P_D | Power Dissipation ($T_C = 25^\circ C$) | 120 | 38 | W |
| | - Derate above $25^\circ C$ | 0.96 | 0.3 | W/ $^\circ C$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | | -55 to +150 | $^\circ C$ |
| T_L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | $^\circ C$ |

* Drain current limited by maximum junction temperature.

Thermal Characteristics

| Symbol | Parameter | SLP60R280S2 | SLF60R280S2 | Units |
|-----------------|---|-------------|-------------|--------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | 1.04 | 3.29 | $^\circ C/W$ |
| $R_{\theta JS}$ | Thermal Resistance, Case-to-Sink Typ. | -- | -- | $^\circ C/W$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5 | 62.5 | $^\circ C/W$ |

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

Off Characteristics

| | | | | | | |
|--|---|--|-----|------|------|---------------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 600 | -- | -- | V |
| $\Delta \text{BV}_{\text{DSS}} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$, Referenced to 25°C | -- | 0.56 | -- | $^\circ\text{C}/\text{V}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{\text{DS}} = 600 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ | -- | -- | 1 | μA |
| | | $V_{\text{DS}} = 480 \text{ V}, T_C = 125^\circ\text{C}$ | -- | -- | 10 | μA |
| I_{GSSF} | Gate-Body Leakage Current, Forward | $V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$ | -- | -- | 100 | nA |
| I_{GSSR} | Gate-Body Leakage Current, Reverse | $V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$ | -- | -- | -100 | nA |

On Characteristics

| | | | | | | |
|---------------------|-----------------------------------|--|-----|------|------|----------|
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$ | 2.0 | -- | 4.0 | V |
| $R_{\text{DS(on)}}$ | Static Drain-Source On-Resistance | $V_{\text{GS}} = 10 \text{ V}, I_D = 7.5 \text{ A}$ | -- | 0.25 | 0.28 | Ω |

Dynamic Characteristics

| | | | | | | |
|------------------|------------------------------|---|----|-----|----|----|
| C_{iss} | Input Capacitance | $V_{\text{DS}} = 100 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$ | -- | 805 | -- | pF |
| C_{oss} | Output Capacitance | | -- | 48 | -- | pF |
| C_{rss} | Reverse Transfer Capacitance | | -- | 3.2 | -- | pF |

Switching Characteristics

| | | | | | | |
|---------------------|---------------------|--|----|-----|----|----|
| $t_{\text{d(on)}}$ | Turn-On Delay Time | $V_{\text{DD}} = 300 \text{ V}, I_D = 15 \text{ A}, R_G = 24 \Omega$ (Note 4, 5) | -- | 15 | -- | ns |
| t_r | Turn-On Rise Time | | -- | 52 | -- | ns |
| $t_{\text{d(off)}}$ | Turn-Off Delay Time | | -- | 117 | -- | ns |
| t_f | Turn-Off Fall Time | | -- | 43 | -- | ns |
| Q_g | Total Gate Charge | $V_{\text{DS}} = 480 \text{ V}, I_D = 15 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5) | -- | 26 | -- | nC |
| Q_{gs} | Gate-Source Charge | | -- | 6.0 | -- | nC |
| Q_{gd} | Gate-Drain Charge | | -- | 13 | -- | nC |

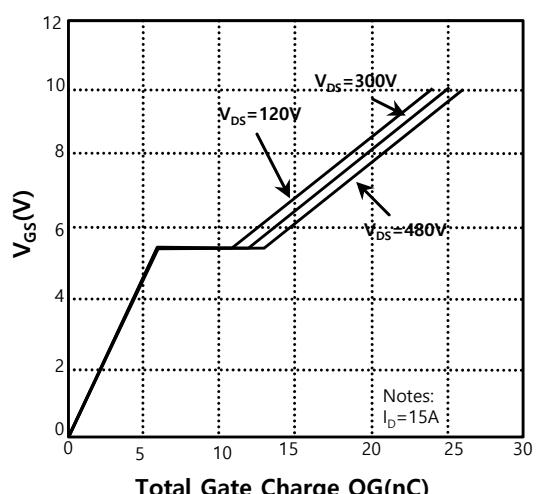
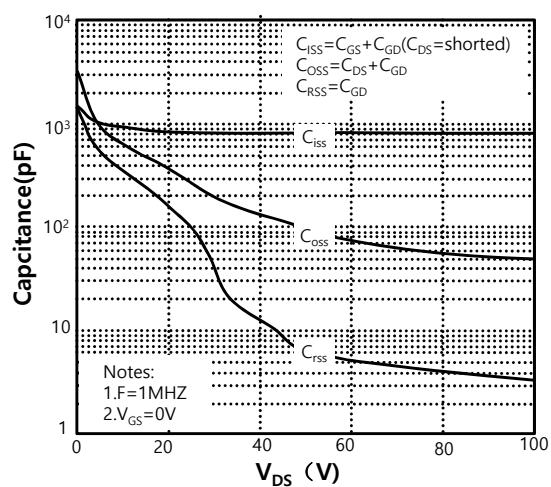
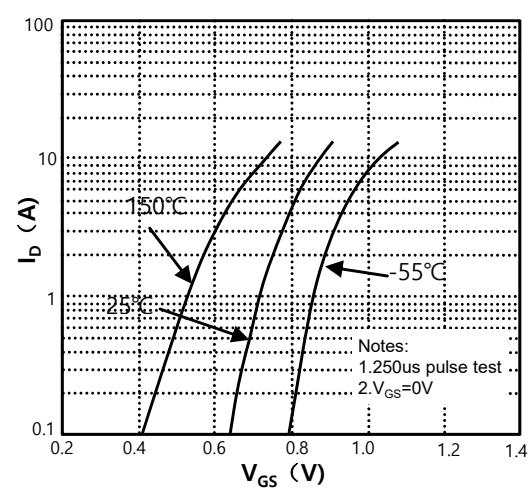
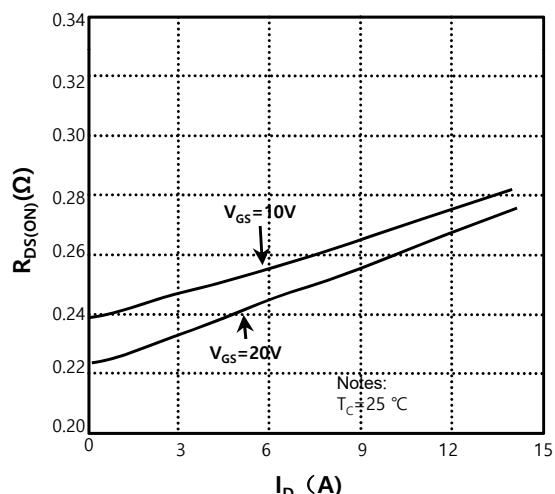
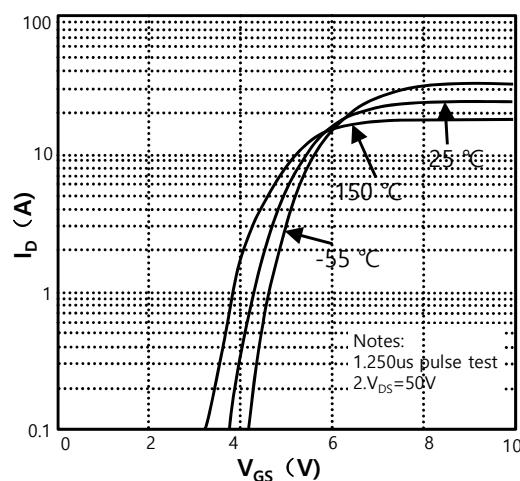
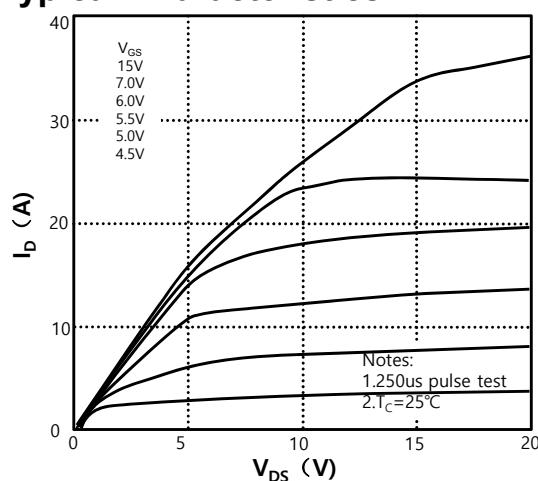
Drain-Source Diode Characteristics and Maximum Ratings

| | | | | | | |
|-----------------|---|--|----|-----|-----|----|
| I_S | Maximum Continuous Drain-Source Diode Forward Current | -- | -- | 11 | A | |
| I_{SM} | Maximum Pulsed Drain-Source Diode Forward Current | -- | -- | 56 | A | |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{\text{GS}} = 0 \text{ V}, I_S = 15 \text{ A}$ | -- | -- | 1.4 | V |
| t_{rr} | Reverse Recovery Time | $V_{\text{GS}} = 50 \text{ V}, I_S = 15 \text{ A}, dI_F / dt = 100 \text{ A/us}$ (Note 4) | -- | 378 | -- | ns |
| Q_{rr} | Reverse Recovery Charge | | -- | 4.6 | -- | uC |

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L = 79 \text{ mH}, I_{\text{AS}} = 3.5 \text{ A}, V_{\text{DD}} = 100 \text{ V}, R_G = 25 \Omega, \text{Starting } T_J = 25^\circ\text{C}$
3. $I_{\text{SD}} \leq 15 \text{ A}, di/dt \leq 100 \text{ A/us}, V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics



Typical Characteristics (Continued)

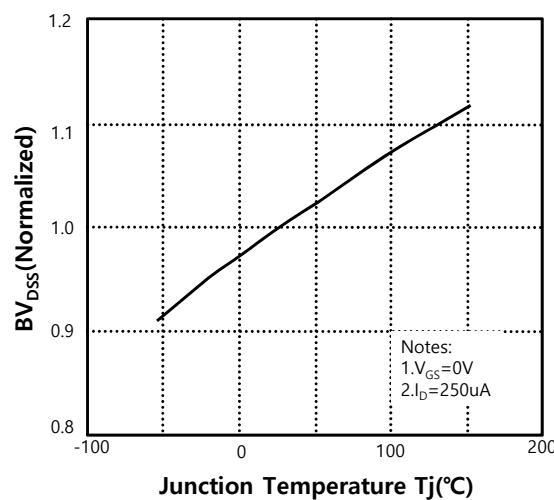


Figure 7. Breakdown Voltage Variation vs Temperature

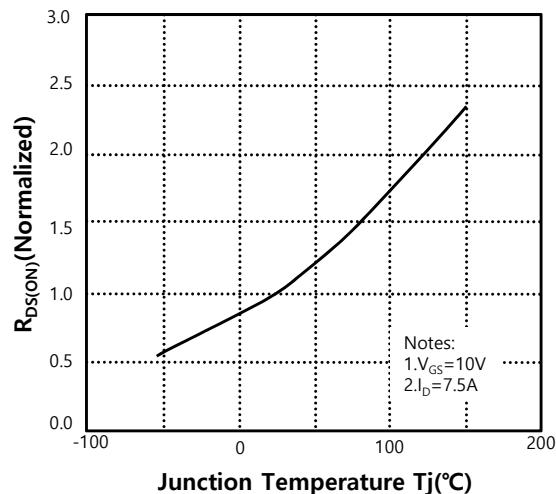


Figure 8. On-Resistance Variation vs Temperature

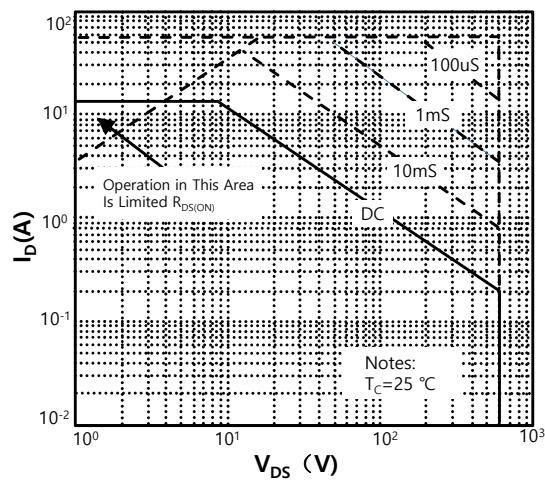


Figure 9-1. Maximum Safe Operating Area (SLP60R280S2)

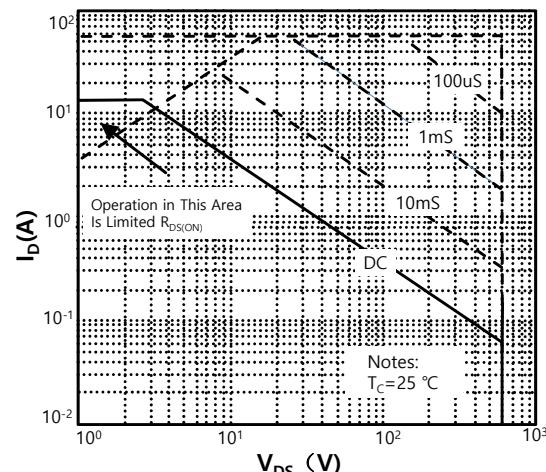


Figure 9-2. Maximum Safe Operating Area (SLF60R280S2)

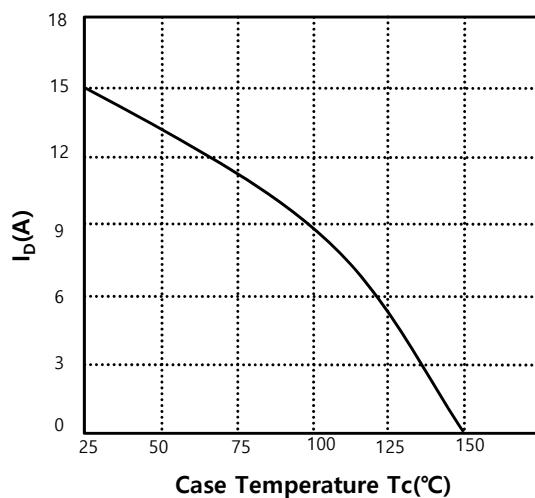
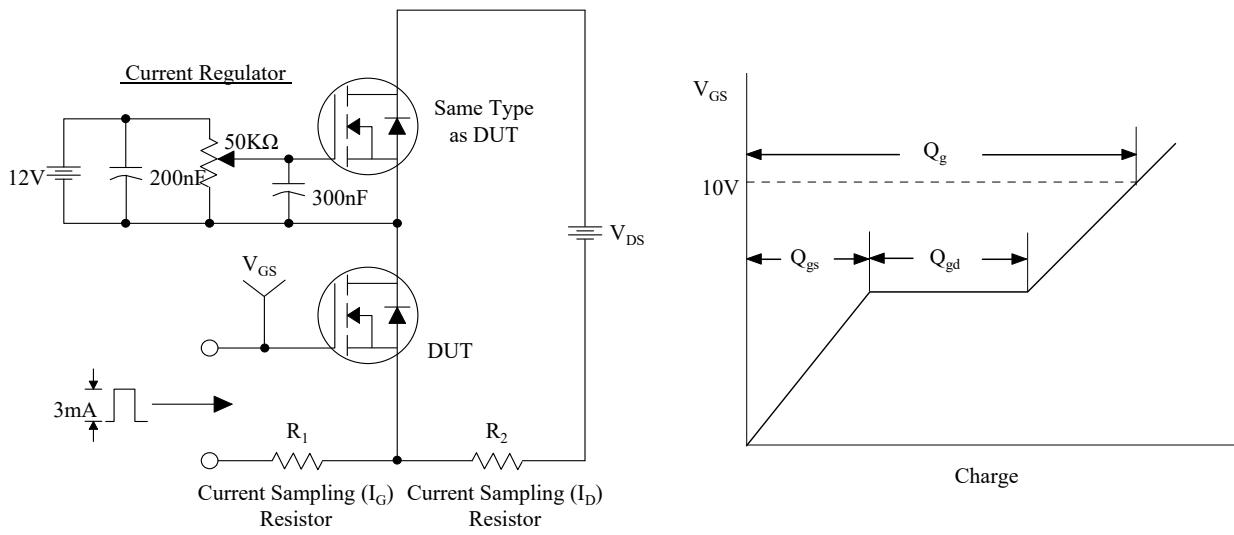
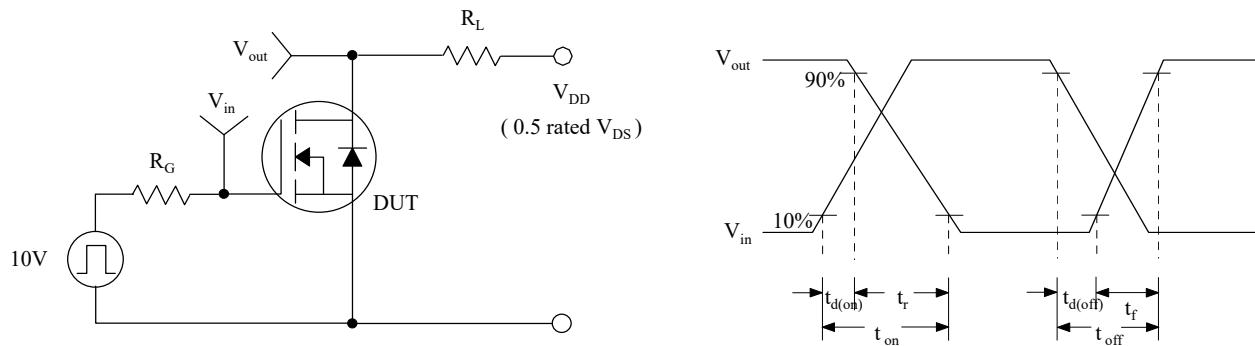


Figure 10. Maximum Drain Current vs Case Temperature

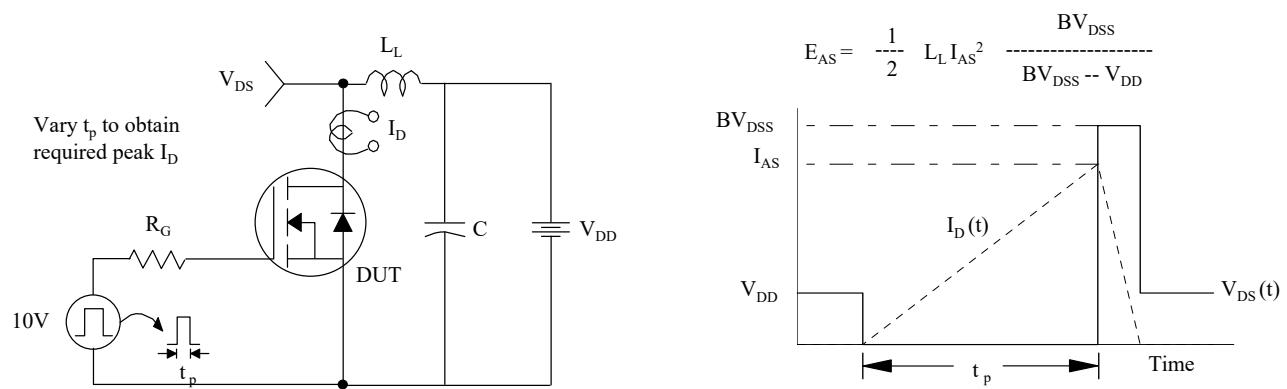
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

